



09/855,454

PATENT

CO/c

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): Agesen et al.

Assignee: Sun Microsystems, Inc.

Title: OBJECT SAMPLING TECHNIQUE FOR RUNTIME OBSERVATIONS
OF REPRESENTATIVE INSTANCES THEREOF

Patent No.: 6,799,191 B2

Issued: September 28, 2004

Atty. Docket No.: 004-4523

May 18, 2005

ATTN: Certificate of Correction Branch
COMMISSIONER FOR PATENTS
P.O. Box 1450
Alexandria, VA 22313-1450

**REQUEST FOR CERTIFICATE OF CORRECTION OF PATENT –
PTO MISTAKE (37 C.F.R. § 1.322(a))**

Dear Sir:

Pursuant to 35 U.S.C. § 254 and 37 C.F.R. § 1.322(a), please issue a Certificate of Correction in the above-identified matter. The mistake(s) to be corrected was made by the Office.

1. Attached hereto is Form PTO/SB/44 (PTO-1050) suitable for printing.
2. The exact page(s) and line number(s) where the error(s) is shown correctly in the application file:
Page 5, paragraph 1016, line 3; and,
Page 9, paragraph 1033, line 5.

3. Please send the Certificate to:

David W. O'Brien
ZAGORIN O'BRIEN GRAHAM LLP
7600B N. CAPITAL OF TEXAS HWY, SUITE 350
AUSTIN, TEXAS 78731-1191

Certificate
MAY 26 2005
of Correction

Respectfully submitted,

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MAY 31 2005

(Also Form PTO-1050)

UNITED STATES PATENT AND TRADEMARK OFFICE
CERTIFICATE OF CORRECTION

PATENT NO : 6,799,191

DATED : September 28, 2004

INVENTOR(S) : Ole Agesen, Alexander T. Garthwaite and Timothy L. Harris

It is certified that error(s) appear(s) in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

Column 3, line 35: "A subset at these objects" should read -- A subset of these objects -- .

Column 6, line 37: "p=malloc (size of (SomeStruct))" should read -- p=malloc(sizeof(SomeStruct)) -- .

MAILING ADDRESS OF SENDER:

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PATENT NO. 6,799,191

MAY 31 2005